

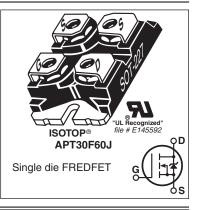


# APT30F60J

## 600V, 31A, 0.15 $\Omega$ Max, t<sub>rr</sub> $\leq$ 270ns

# **N-Channel FREDFET**

Power MOS 8<sup>™</sup> is a high speed, high voltage N-channel switch-mode power MOSFET. This 'FREDFET' version has a drain-source (body) diode that has been optimized for high reliability in ZVS phase shifted bridge and other circuits through reduced trr, soft recovery, and high recovery dv/dt capability. Low gate charge, high gain, and a greatly reduced ratio of C<sub>rss</sub>/C<sub>iss</sub> result in excellent noise immunity and low switching loss. The intrinsic gate resistance and capacitance of the poly-silicon gate structure help control di/dt during switching, resulting in low EMI and reliable paralleling, even when switching at very high frequency.



## **FEATURES**

- · Fast switching with low EMI
- · Low trr for high reliability
- Ultra low C<sub>rss</sub> for improved noise immunity
- · Low gate charge
- · Avalanche energy rated
- RoHS compliant *J*

# **TYPICAL APPLICATIONS**

- · ZVS phase shifted and other full bridge
- Half bridge
- · PFC and other boost converter
- Buck converter
- · Single and two switch forward
- Flyback

#### Absolute Maximum Ratings Symbol Parameter Ratings Unit Continuous Drain Current @ T<sub>C</sub> = 25°C 31 I<sub>D</sub> Continuous Drain Current @ $T_{C} = 100^{\circ}C$ 19 A I<sub>DM</sub> Pulsed Drain Current<sup>①</sup> 160 V<sub>GS</sub> V Gate-Source Voltage ±30 EAS 1200 Single Pulse Avalanche Energy<sup>2</sup> mJ I<sub>AR</sub> Avalanche Current, Repetitive or Non-Repetitive 21 A

## **Thermal and Mechanical Characteristics**

Symbol	Characteristic	Min	Тур	Мах	Unit	
P <sub>D</sub>	Total Power Dissipation @ $T_{C} = 25^{\circ}C$			355	W	
R <sub>eJC</sub>	Junction to Case Thermal Resistance			0.35 °C/W		
$R_{ ext{ heta}CS}$	Case to Sink Thermal Resistance, Flat, Greased Surface		0.15		0/00	
T <sub>J</sub> ,T <sub>STG</sub>	Operating and Storage Junction Temperature Range	-55		150	°C	
V <sub>Isolation</sub>	RMS Voltage (50-60hHz Sinusoidal Waveform from Terminals to Mounting Base for 1 Min.)	2500			V	
W <sub>T</sub>	Package Weight		1.03		ΟZ	
			29.2		g	
Torque	Terminele and Mounting Corour			10	in∙lbf	
	Terminals and Mounting Screws.			1.1	N∙m	

## (MicrosemiWebsite-http://www.microsemi.com)

**Static Characteristics** 

#### $T_{.1} = 25^{\circ}C$ unless otherwise specified

**APT30F60J** 

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Symbol	Parameter	Test Conditions		Min	Тур	Max	Unit	
V <sub>BR(DSS)</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0V, I_{D} = 250 \mu A$		600			V	
$\Delta V_{BR(DSS)} / \Delta T_{J}$	Breakdown Voltage Temperature Coefficient	Reference to 25°C, $I_D = 250\mu A$			0.57		V/°C	
R <sub>DS(on)</sub>	Drain-Source On Resistance <sup>③</sup>	$V_{GS} = 10V, I_D = 21A$			0.12	0.15	Ω	
V <sub>GS(th)</sub>	Gate-Source Threshold Voltage	$V_{GS} = V_{DS}, I_D = 2.5 \text{mA}$		2.5	4	5	V	
$\Delta V_{GS(th)} / \Delta T_J$	Threshold Voltage Temperature Coefficient				-10		mV/°C	
	Zero Gate Voltage Drain Current	$V_{DS} = 600V$	$T_J = 25^{\circ}C$			250	μA	
DSS		$V_{GS} = 0V$	T <sub>J</sub> = 125°C			1000	] μΛ	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS} = \pm 30V$				±100	nA	

#### **Dynamic Characteristics**

#### T<sub>J</sub> = 25°C unless otherwise specified

Symbol	Parameter	Test Conditions	Min	Тур	Max	Unit
9 <sub>fs</sub>	Forward Transconductance	$V_{DS} = 50V, I_{D} = 21A$		42		S
C <sub>iss</sub>	Input Capacitance			8590		
C <sub>rss</sub>	Reverse Transfer Capacitance	$V_{GS} = 0V, V_{DS} = 25V$ f = 1MHz		90		
C <sub>oss</sub>	Output Capacitance			800		
C <sub>o(cr)</sub> ⊕	Effective Output Capacitance, Charge Related			420		pF
C <sub>o(er)</sub> (5)	Effective Output Capacitance, Energy Related	$V_{GS} = 0V, V_{DS} = 0V \text{ to } 400V$		220		
Q <sub>g</sub>	Total Gate Charge	$V_{GS} = 0 \text{ to } 10V, I_{D} = 21A,$		215		nC
Q <sub>gs</sub>	Gate-Source Charge			45		
Q <sub>gd</sub>	Gate-Drain Charge	$V_{\rm DS} = 300V$		90		
t <sub>d(on)</sub>	Turn-On Delay Time	Resistive Switching		48		
t <sub>r</sub>	Current Rise Time	V <sub>DD</sub> = 400V, I <sub>D</sub> = 21A		55		ns
t <sub>d(off)</sub>	Turn-Off Delay Time	$R_{G} = 4.7 \Omega^{\textcircled{6}}, V_{GG} = 15V$		145		115
t <sub>f</sub>	Current Fall Time			44		

## **Source-Drain Diode Characteristics**

Symbol	Parameter	Test Conditions	Min	Тур	Мах	Unit
۱ <sub>s</sub>	Continuous Source Current (Body Diode)	MOSFET symbol showing the			31	А
I <sub>SM</sub>	Pulsed Source Current (Body Diode) <sup>①</sup>	integral reverse p-n junction diode (body diode)			160	A
V <sub>SD</sub>	Diode Forward Voltage	$I_{SD} = 21A, T_{J} = 25^{\circ}C, V_{GS} = 0V$			1.0	V
t <sub>rr</sub>	Reverse Recovery Time	$T_{J} = 25^{\circ}C$			270	ns
rr		$T_{J} = 125^{\circ}C$			500	115
Q <sub>rr</sub>	Reverse Recovery Charge	$I_{SD} = 21A^{(3)}$ $T_J = 25^{\circ}C$		1.14		
~rr		$di_{SD}/dt = 100A/\mu s$ $T_J = 125^{\circ}C$		2.91		μC
	Reverse Recovery Current	$V_{DD} = 100V$ $T_J = 25^{\circ}C$		9.6		Α
rrm		$T_{J} = 125^{\circ}C$		13.8		А
dv/dt	Peak Recovery dv/dt	$I_{SD} \le 21A$ , di/dt $\le 1000A/\mu$ s, $V_{DD} = 400V$ , $T_J = 125^{\circ}C$			20	V/ns

(1) Repetitive Rating: Pulse width and case temperature limited by maximum junction temperature.

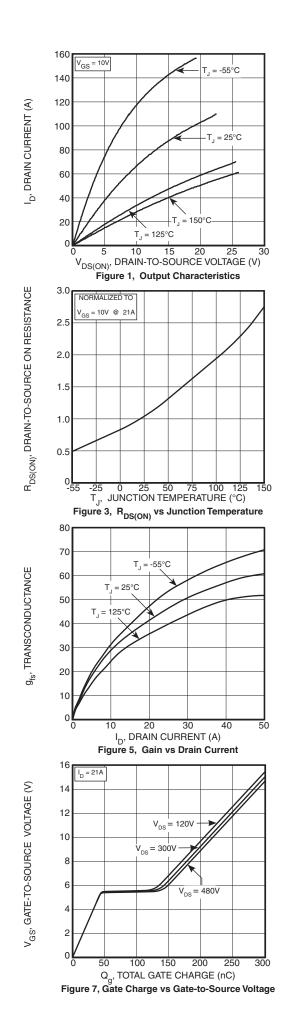
(2) Starting at  $T_J = 25^{\circ}$ C, L = 5.44mH,  $R_G = 25\Omega$ ,  $I_{AS} = 21$ A.

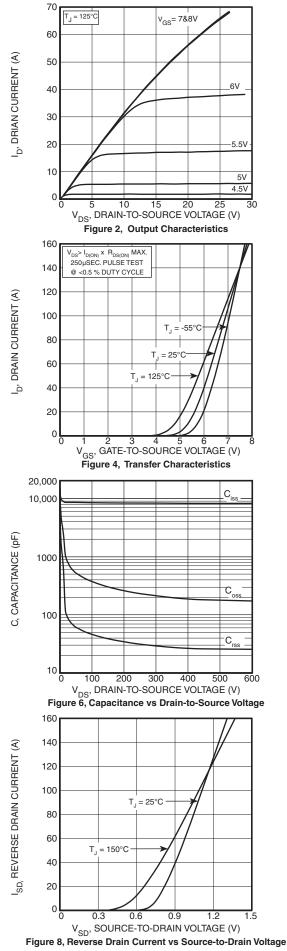
(3) Pulse test: Pulse Width <  $380\mu$ s, duty cycle < 2%.

(4) C<sub>o(cr)</sub> is defined as a fixed capacitance with the same stored charge as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>.
(5) C<sub>o(er)</sub> is defined as a fixed capacitance with the same stored energy as C<sub>OSS</sub> with V<sub>DS</sub> = 67% of V<sub>(BR)DSS</sub>. To calculate C<sub>o(er)</sub> for any value of V<sub>DS</sub> less than V<sub>(BR)DSS</sub>, use this equation: C<sub>o(er)</sub> = -8.32E-8/V<sub>DS</sub>^2 + 3.49E-8/V<sub>DS</sub> + 1.30E-10.

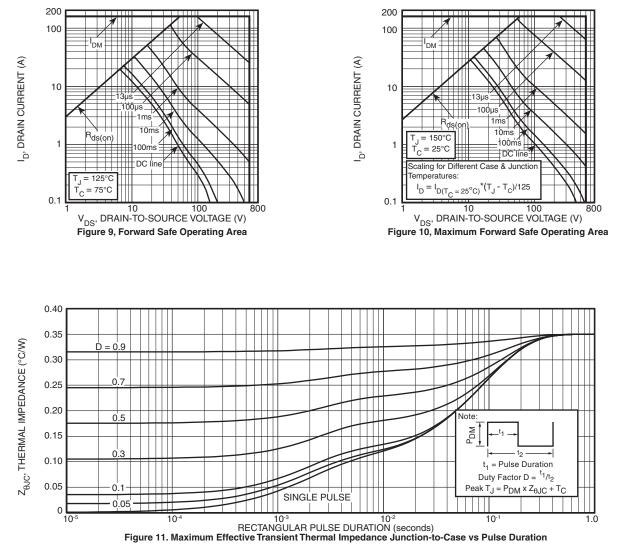
6 R<sub>G</sub> is external gate resistance, not including internal gate resistance or gate driver impedance. (MIC4452)

Microsemi reserves the right to change, without notice, the specifications and information contained herein.

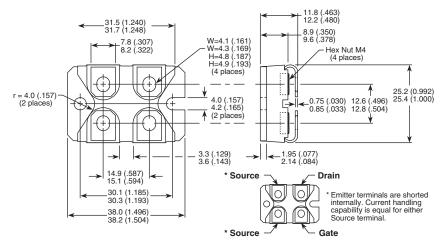












Dimensions in Millimeters and (Inches)

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